# Ultra Low Noise, High PSSR, BiCMOS RF LDO Regulator

Noise sensitive RF applications such as Power Amplifiers in cell phones and precision instrumentation require very clean power supplies.

The NCP700 is 150 mA LDO that provides the engineer with a very stable, accurate voltage with ultra low noise and very high Power Supply Rejection Ratio (PSRR) suitable for RF applications. In order to optimize performance for battery operated portable applications, the NCP700 employs an advanced BiCMOS process to combine the benefits of low noise and superior dynamic performance of bipolar elements with very low ground current consumption at full loads offered by CMOS.

Furthermore, in order to provide a small footprint for space-conscious applications, the NCP700 is stable with small, low value capacitors and is available in a very small DFN6 2x2.2 package.

## **Features**

- Output Voltage Options:
  - 1.8 V, 2.8 V, 3.0 V
  - Contact Factory for Other Voltage Options
- Ultra Low Noise (typ 15 μV<sub>rms</sub>)
- Very High PSRR (typ 80 dB)
- Stable with Ceramic Output Capacitors as low as 1 μF
- Low Sleep Mode Current (max 1 μA)
- Active Discharge Circuit
- Current Limit Protection
- Thermal Shutdown Protection
- These are Pb-Free Devices

# **Typical Applications**

- Cellular Telephones (Power Amplifier)
- Noise Sensitive Applications (Video, Audio)
- Analog Power Supplies
- PDAs / Palmtops / Organizers / GPS
- Battery Supplied Devices

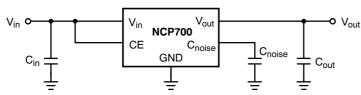


Figure 1. Typical Application Schematic



# ON Semiconductor®

http://onsemi.com



CASE 506BA

# MARKING DIAGRAM



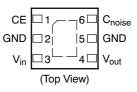
XX = Specific Device Code

= Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

# PIN ASSIGNMENT



## **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 8 of this data sheet.

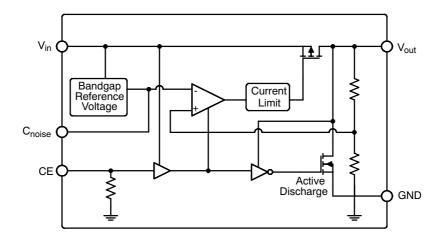


Figure 2. Simplified Block Diagram

# PIN FUNCTION DESCRIPTION

DFN6 2x2.2 Pin No.	Pin Name	Description				
1	CE	Chip Enable: This pin allows on/off control of the regulator. To disable the device, connect to GND. If this function is not in use, connect to $V_{in}$ . Internal 5 M $\Omega$ Pull Down resistor is connected between CE and GND.				
2, 5, EPAD	GND	Power Supply Ground (Pins are fused for the DFN package)				
3	V <sub>in</sub>	Power Supply Input Voltage				
4	V <sub>out</sub>	Regulated Output Voltage				
6	C <sub>noise</sub>	Noise reduction pin. (Connect 100 nF or 10 nF capacitor to GND)				

# **MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Input Voltage (Note 1)	V <sub>in</sub>	-0.3 V to 6 V	V
Chip Enable Voltage	V <sub>CE</sub>	-0.3 V to V <sub>in</sub> +0.3 V	V
Noise Reduction Voltage	V <sub>Cnoise</sub>	-0.3 V to V <sub>in</sub> +0.3 V	V
Output Voltage	V <sub>out</sub>	-0.3 V to V <sub>in</sub> +0.3 V	V
Maximum Junction Temperature (Note 1)	T <sub>J(max)</sub>	150	°C
Storage Temperature Range	T <sub>STG</sub>	-55 to 150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

NOTE: This device series contains ESD protection and exceeds the following tests:

Human Body Model 2000 V per MIL-STD-883, Method 3015

Machine Model Method 200 V

# THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Package Thermal Resistance, DFN6: (Note 1) Junction-to-Lead (pin 2) Junction-to-Ambient	$R_{ hetaJA}$	37 120	°C/W

1. Refer to ELECTRICAL CHARACTERISTICS and APPLICATION INFORMATION for Safe Operating Area

# **ELECTRICAL CHARACTERISTICS**

 $(V_{in} = V_{out} + 1.0 \text{ V}, V_{CE} = 1.2 \text{ V}, C_{in} = 0.1 \text{ } \mu\text{F}, C_{out} = 1 \text{ } \mu\text{F}, C_{noise} = 10 \text{ nF}, T_{A} = -40 ^{\circ}\text{C} \text{ to } 85 ^{\circ}\text{C}, unless \text{ otherwise specified (Note 2))}$ 

Characteristic		Test Conditions	Symbol	Min	Тур	Max	Unit
REGULATOR OUTPUT							
Input Voltage			V <sub>in</sub>	2.5	-	5.5	V
Output Voltage (Note 3) 1.8		V <sub>in</sub> = (V <sub>out</sub> +1.0 V) to 5.5 V	V <sub>out</sub>	1.764	-	1.836	V
	2.8 V	I <sub>out</sub> = 1 mA		2.744	-	2.856	
	3.0 V			2.940	-	3.060	
Output Voltage (Note 3)	1.8 V	V <sub>in</sub> = (V <sub>out</sub> +1.0 V) to 5.5 V	V <sub>out</sub>	1.746	-	1.854	V
	2.8 V	I <sub>out</sub> = 1 mA to 150 mA		2.716	-	2.884	
	3.0 V			2.910	-	3.090	
Power Supply Ripple Rejection		$V_{in} = V_{out} + 1.0 \text{ V} + 0.5 \text{ V}_{p-p}$	PSRR				dB
		I <sub>out</sub> = 1 mA to 150 mA f = 120 Hz		-	80	-	
		$C_{\text{noise}} = 100 \text{nF}$ f = 1 kHz		-	80	-	
		f = 10 kHz		-	65	-	
Line Regulation		$V_{in} = (V_{out} + 1.0 \text{ V}) \text{ to } 5.5 \text{ V}, I_{out} = 1 \text{ mA}$	Reg <sub>line</sub>	-0.2	-	0.2	%/V
Load Regulation		I <sub>out</sub> = 1 mA to 150 mA	Reg <sub>load</sub>	-	12	25	mV
Output Noise Voltage		f = 10 Hz to 100 kHz	V <sub>n</sub>				$\mu V_{rms}$
		$I_{out} = 1 \text{ mA to } 150 \text{ mA } C_{noise} = 100 \text{ nF}$		-	15	-	
		C <sub>noise</sub> = 10 nF		-	20	-	
Output Current Limit		$V_{out} = V_{out(nom)} - 0.1 \text{ V}$	I <sub>LIM</sub>	150	310	470	mA
Output Short Circuit Current		V <sub>out</sub> = 0 V	I <sub>SC</sub>	150	320	490	mA
Dropout Voltage (Note 4)	2.8 V	I <sub>out</sub> = 150 mA	$V_{DO}$	-	105	155	mV
	3.0 V			-	100	150	
GENERAL							
Ground Current		I <sub>out</sub> = 1 mA	I <sub>GND</sub>	-	70	90	μΑ
		I <sub>out</sub> = 150 mA		-	110	220	
Disable Current		V <sub>CE</sub> = 0 V	I <sub>DIS</sub>	-	0.1	1	μΑ
Thermal Shutdown Threshold (Note 5)			T <sub>SD</sub>	-	150	-	°C
Thermal Shutdown Hysteresis (N	lote 5)		T <sub>SH</sub>	-	20	-	°C
CHIP ENABLE							
Input Threshold	Low		V <sub>th(CE)</sub>	-	-	0.4	V
	High		, ,	1.2	-	-	
Internal Pull-Down Resistance (Note 6)			R <sub>PD(CE)</sub>	2.5	5	10	МΩ
TIMING							
Turn-on Time		I <sub>out</sub> = 150 mA	t <sub>on</sub>	-	0.4	-	ms
		C <sub>noise</sub> = 100 nF		-	4	-	
Turn-off Time		C <sub>noise</sub> = 10 nF/100 nF	t <sub>off</sub>	-	800	-	μS
		I <sub>out</sub> = 10 mA		-	200	-	
		out -					

Performance guaranteed over the indicated operating temperature range by design and/or characterization, production tested at T<sub>J</sub> = T<sub>A</sub> = 25°C. Low duty cycle pulse techniques are used during testing to maintain the junction temperature as close to ambient as possible.
 Contact factory for other voltage options.
 Measured when the output voltage falls 100 mV below the regulated voltage at V<sub>in</sub> = V<sub>out</sub> + 1.0 V If V<sub>out</sub> < 2.5 V, then V<sub>DO</sub> = V<sub>in</sub> - V<sub>out</sub> at V<sub>in</sub> = 2.5 V.
 Guaranteed by design and characterization.
 Expected to disable device when CE pin is floating.

## TYPICAL CHARACTERISTICS

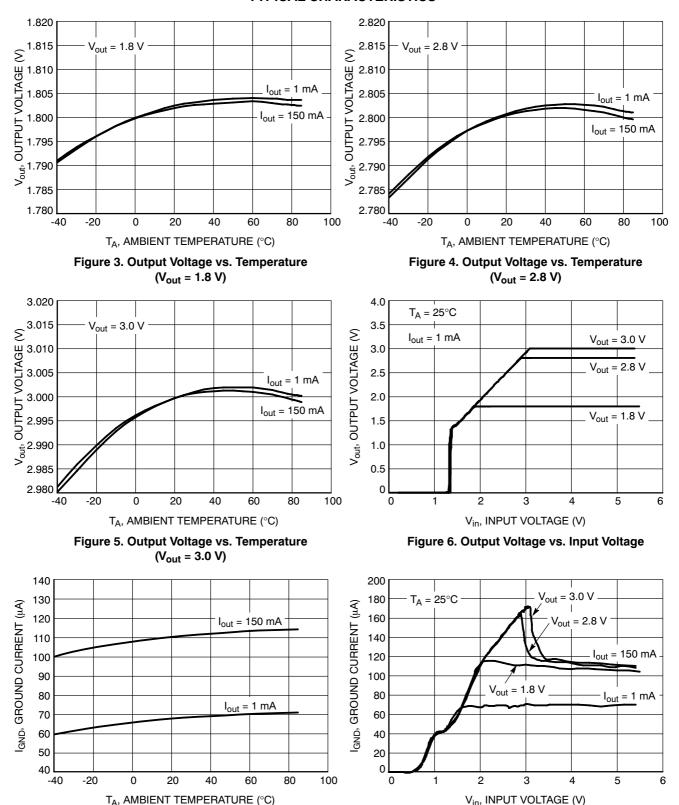
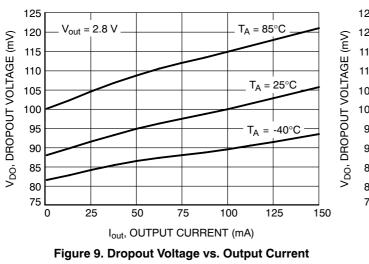


Figure 7. Ground Current vs. Temperature

Figure 8. Ground Current vs. Input Voltage

# **TYPICAL CHARACTERISTICS**



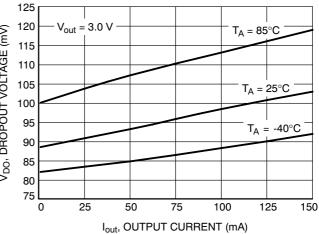
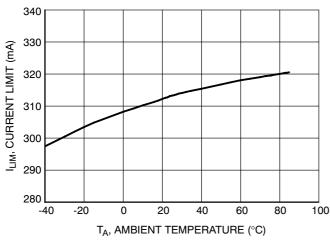


Figure 10. Dropout Voltage vs. Output Current



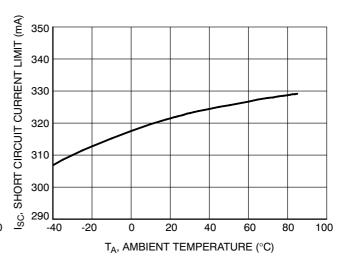
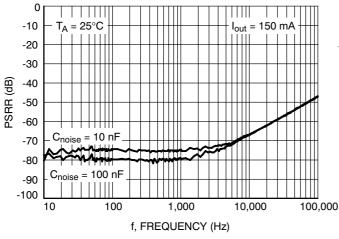


Figure 11. Current Limit vs. Temperature

Figure 12. Short Circuit Current vs. Temperature



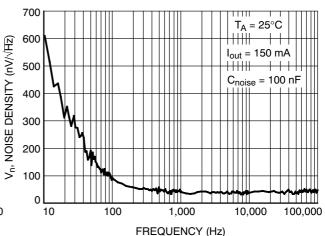


Figure 13. PSRR vs. Frequency

Figure 14. Noise Density vs. Frequency

# **TYPICAL CHARACTERISTICS**

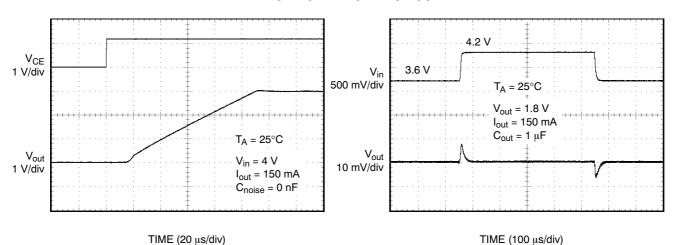


Figure 15. Enable Voltage and Output Voltage vs. Time (Start-Up)

Figure 16. Line Transient

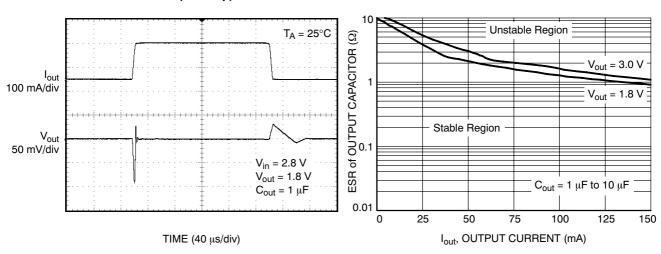


Figure 17. Load Transient

Figure 18. Output Capacitor ESR vs. Output Current

## APPLICATION INFORMATION

#### General

The NCP700 is a 150 mA (current limited) linear regulator with a logic input for on/off control for the high speed turn-off output voltage.

Access to the major contributor of noise within the integrated circuit is provided as the focus for noise reduction within the linear regulator system.

## Power Up/Down

During power up, the NCP700 maintains a high impedance output  $(V_{out})$  until sufficient voltage is present on  $V_{in}$  to power the internal bandgap reference voltage. When sufficient voltage is supplied (approx 1.2 V),  $V_{out}$  will start to turn on (assume CE shorted to  $V_{in}$ ), linearly increasing until the output regulation voltage has been reached.

Active discharge circuitry has been implemented to insure a fast turn off time. Then CE goes low, the active discharge transistor turns on creating a fast discharge of the output voltage. Power to drive this circuitry is drawn from the output node. This is to maintain the lowest quiescent current when in the sleep mode ( $V_{CE} = 0.4 \text{ V}$ ). This circuitry subsequently turns off when the output voltage discharges.

## CE (chip enable)

The enable function is controller by the logic pin CE. The voltage threshold of this pin is set between 0.4 V and 1.2 V. A voltage lower than 0.4 V guarantees the device is off. A voltage higher than 1.2 V guarantees the device is on. The NCP700 enters a sleep mode when in the off state drawing less than 1  $\mu$ A of quiescent current.

The device can be used as a simple regulator without use of the chip enable feature by tying the CE pin to the  $V_{in}$  pin.

## **Current Limit**

Output Current is internally limited within the IC to a minimum of 150 mA. The design is set to a higher value to allow for variation in processing and the temperature coefficient of the parameter. The NCP700 will source this amount of current measured with a voltage 100 mV lower than the typical operating output voltage.

The specification for short circuit current limit (@ $V_{out} = 0 V$ ) is specified at 320 mA (typ). There is no additional circuitry to lower the current limit at low output voltages. This number is provided for informational purposes only.

## **Output Capacitor**

The NCP700 has been designed to work with low ESR ceramic capacitors. There is no ESR lower limit for stability for the recommended 1  $\mu$ F output capacitor. Stable region for Output capacitor ESR vs Output Current is shown in Figure 18.

#### **Output Noise**

The main contributor for noise present on the output pin  $V_{out}$  is the reference voltage node. This is because any noise which is generated at this node will be subsequently amplified through the error amplifier and the PMOS pass device. Access to the reference voltage node is supplied directly through the  $C_{noise}$  pin. Noise can be reduced from a typical value of 20  $\mu V_{rms}$  by using 10 nF to 15  $\mu V_{rms}$  by using a 100 nF from the  $C_{noise}$  pin to ground.

A bypass capacitor is recommended for good noise performance and better load transient response.

#### Thermal Shutdown

When the die temperature exceeds the Thermal Shutdown threshold, a Thermal Shutdown (TSD) event is detected and the output (V<sub>out</sub>) is turned off. There is no effect from the active discharge circuitry. The IC will remain in this state until the die temperature moves below the shutdown threshold (150°C typical) minus the hysteresis factor (20°C typical).

This feature provides protection from a catastrophic device failure due to accidental overheating. It is not intended to be used as a substitute for proper heat sinking. The maximum device power dissipation can be calculated by:

$$P_{D} = \frac{T_{J} - T_{A}}{R_{\theta JA}}$$

Thermal resistance value versus copper area and package is shown in Figure 19.

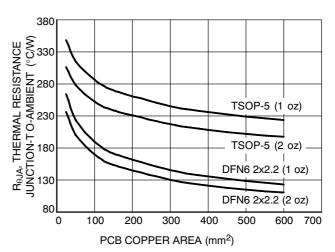


Figure 19.  $R_{\theta JA}$  vs. PCB Copper Area

(TSOP-5 for comparison only)

## **ORDERING INFORMATION**

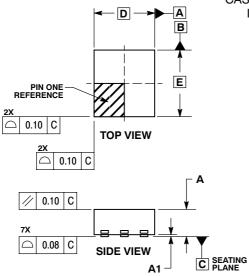
Device	Nominal Output Voltage	Marking	Package	Shipping†
NCP700MN180R2G	1.8 V	LZ	DFN6	3000 / Tape & Reel
NCP700MN280R2G	2.8 V	LX	2x2.2 Pb-Free	
NCP700MN300R2G	3.0 V	LY	1 5 1 100	

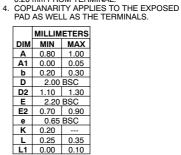
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## PACKAGE DIMENSIONS

# 6 PIN DFN, 2x2.2, 0.65P

CASE 506BA-01 ISSUE O

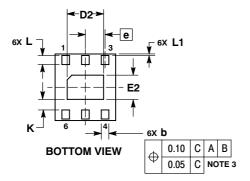




NOTES:
1. DIMENSIONING AND TOLERANCING PER

0.20 mm FROM TERMINAL.

ASME Y14.5M, 1994.
CONTROLLING DIMENSION: MILLIMETERS.
DIMENSION & APPLIES TO PLATED TERMINAL
AND IS MEASURED BETWEEN 0.15 AND



The products described herein (NCP700), may be covered by one or more U.S. patents.

ON Semiconductor and are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

## **PUBLICATION ORDERING INFORMATION**

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center
Phone: 81-3-5773-3850

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative